

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
120V	3.7mΩ@10V	180A



合肥矽普半导体

Siliup Semiconductor Technology Co., Ltd

技术 品质 服务

www.siliup.com

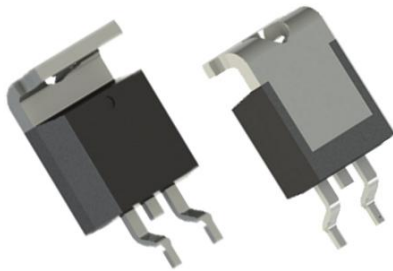
Feature

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

Applications

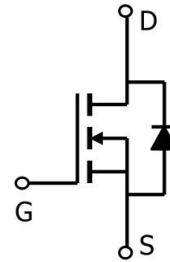
- High Speed Power switching
- DC-DC Converter
- Power Management

Package

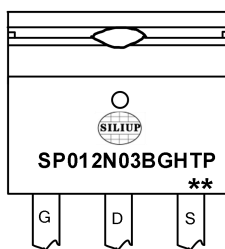


TO-220R

Circuit diagram



Marking



SP012N03BGHTP :Product code
** :Week code

Order Information

Device	Package	Unit/Tube
SP012N03BGHTP	TO-220R	50

Absolute maximum ratings (Ta=25°C unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	120	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current (Tc=25°C)	I_D	180	A
Continuous Drain Current (Tc=100°C)	I_D	120	A
Pulsed Drain Current	I_{DM}	720	A
Single Pulse Avalanche Energy ¹	E_{AS}	900	mJ
Power Dissipation (Tc=25°C)	P_D	230	W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	0.54	°C/W
Storage Temperature Range	T_{STG}	-55 to 150	°C
Operating Junction Temperature Range	T_J	-55 to 150	°C

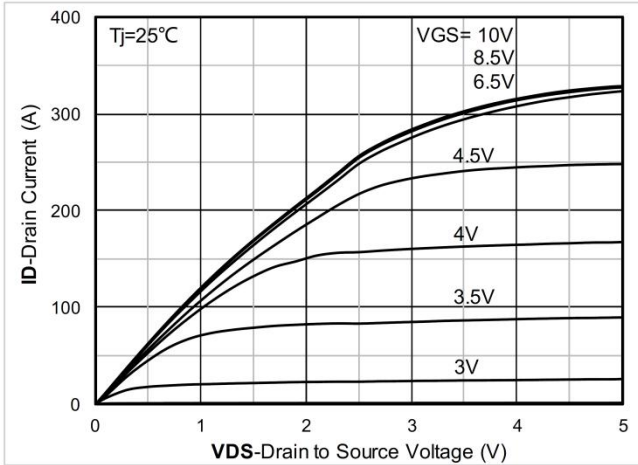
Electrical characteristics (Ta=25°C, unless otherwise noted)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D = 250\mu A, V_{GS} = 0V$	120	-	-	V
Drain Cut-Off Current	I_{DSS}	$V_{DS} = 96V, V_{GS} = 0V$	-	-	1	μA
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	± 0.1	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	3.0	4.0	V
Drain-Source ON Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 50A$	-	3.7	4.6	m Ω
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 60V, V_{GS} = 0V, f = 1.0MHz$	-	5640	-	pF
Output Capacitance	C_{oss}		-	835	-	
Reverse Transfer Capacitance	C_{rss}		-	13	-	
Total Gate Charge	Q_g	$V_{DS}=60V, V_{GS}=10V, I_D=75A$	-	152	-	nC
Gate-Source Charge	Q_{gs}		-	43	-	
Gate-Drain Charge	Q_{gd}		-	46	-	
Switching Characteristics						
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10V, V_{DS} = 50V, I_D = 75A$ $RG = 1.6\Omega$	-	25	-	nS
Rise Time	t_r		-	15	-	
Turn-Off Delay Time	$t_{d(off)}$		-	52	-	
Fall Time	t_f		-	18	-	
Drain-Source Body Diode Characteristics						
Source-Drain Diode Forward Voltage	V_{SD}	$I_S = 1A, V_{GS} = 0V$	-	-	1.2	V
Maximum Body-Diode Continuous Current	I_S		-	-	180	A
Reverse Recovery Time	T_{rr}	$I_S=100A, di/dt=100A/us, T_J=25^{\circ}C$	-	92	-	nS
Reverse Recovery Charge	Q_{rr}		-	183	-	nC

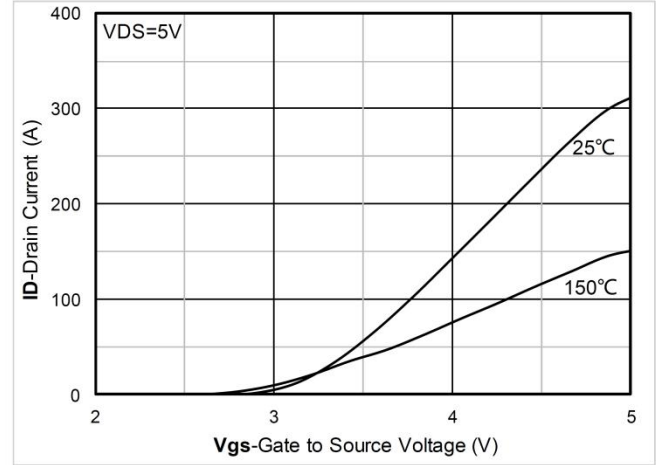
Note :

1. The test condition is $V_{DD}=50V, V_{GS}=10V, L=0.5mH, RG=25\Omega$

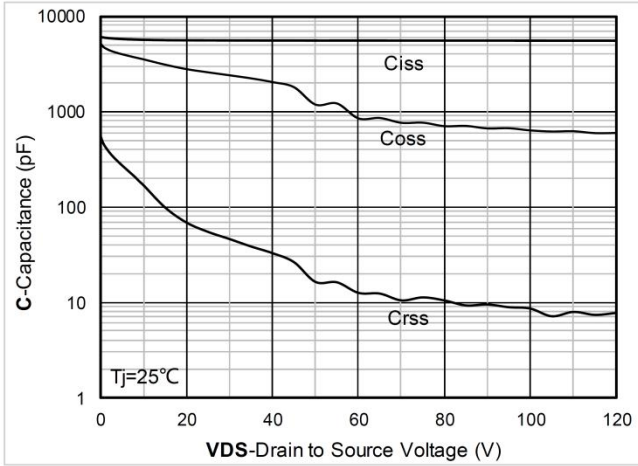
Typical Characteristics



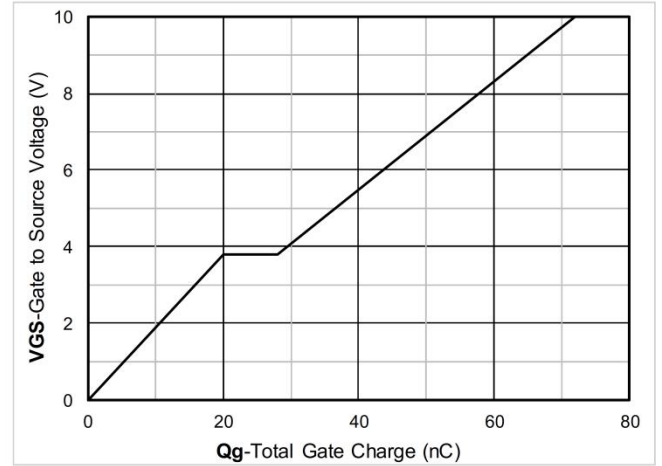
Output Characteristics



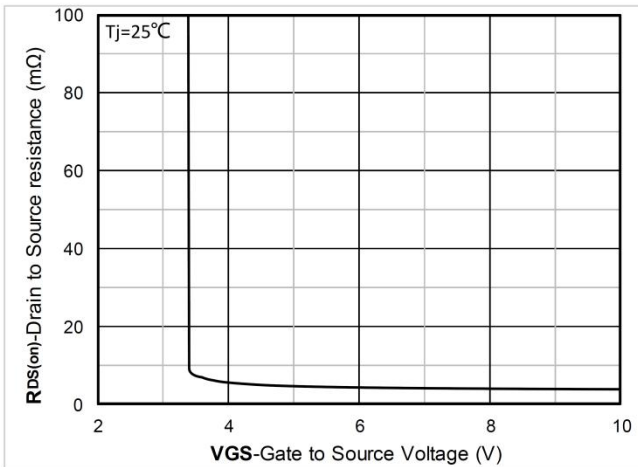
Transfer Characteristics



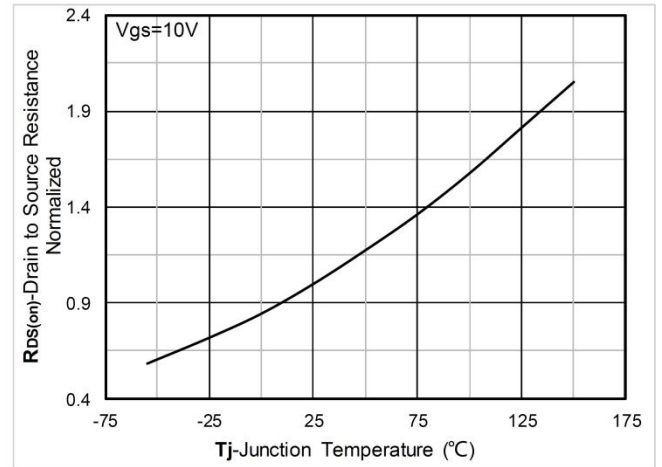
Capacitance Characteristics



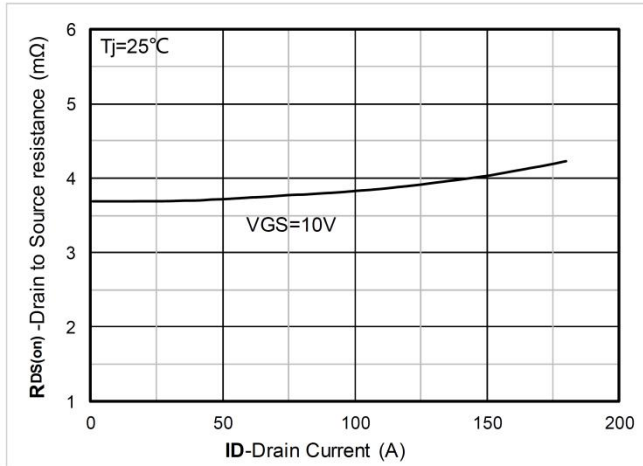
Gate Charge



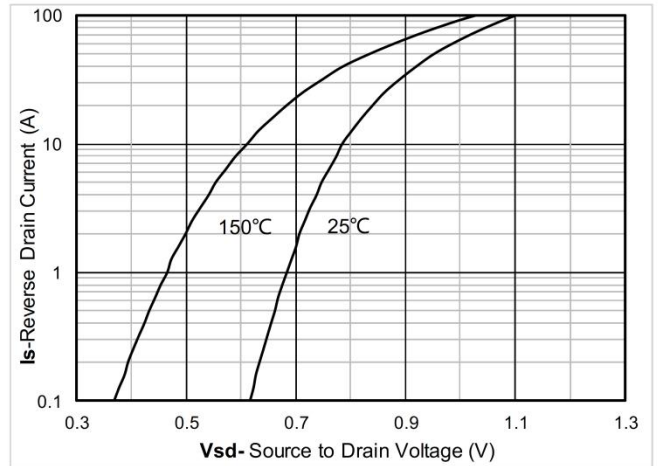
On-Resistance vs Gate to Source Voltage



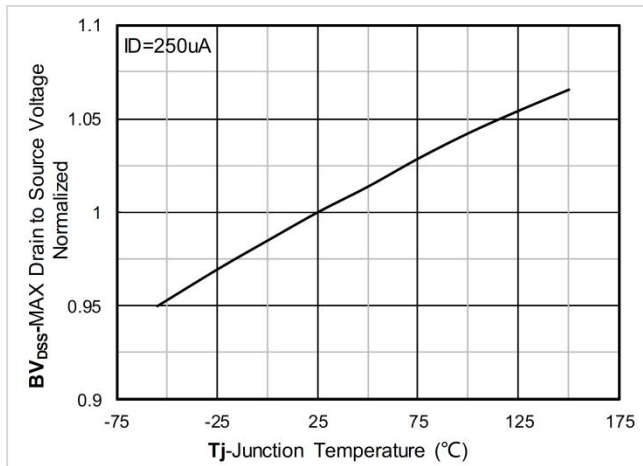
Normalized On-Resistance



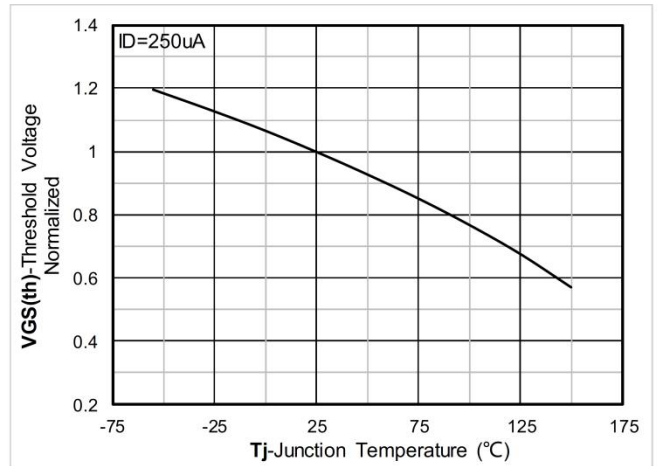
$R_{DS(on)}$ VS Drain Current



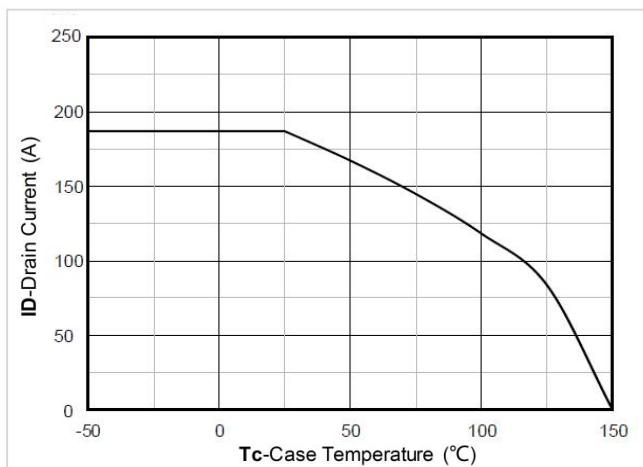
Forward characteristics of reverse diode



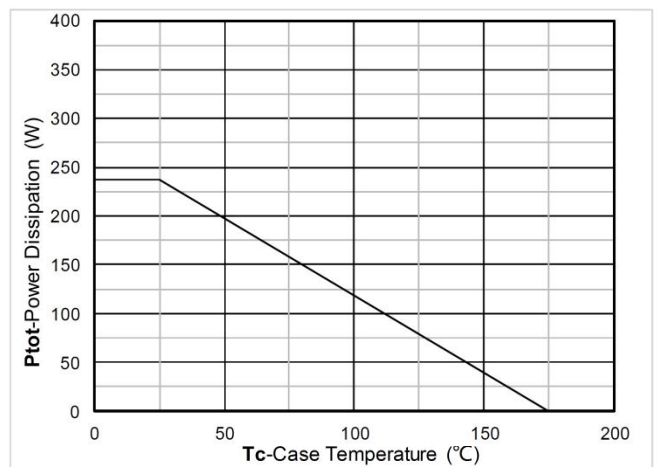
Normalized breakdown voltage



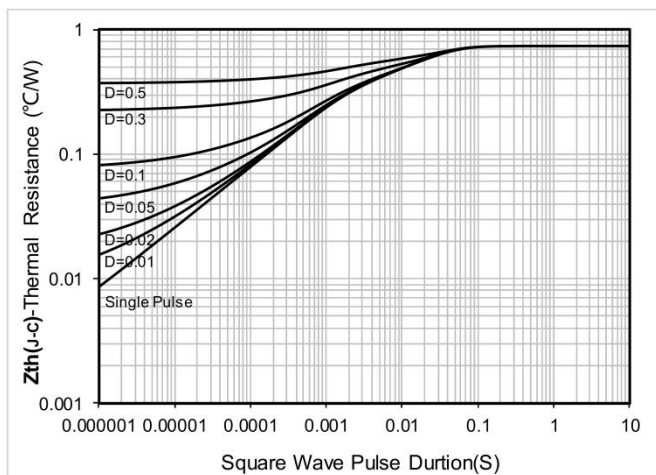
Normalized Threshold voltage



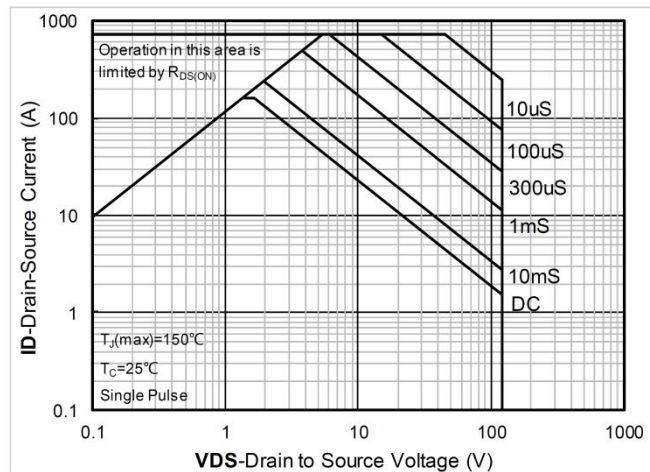
Current dissipation



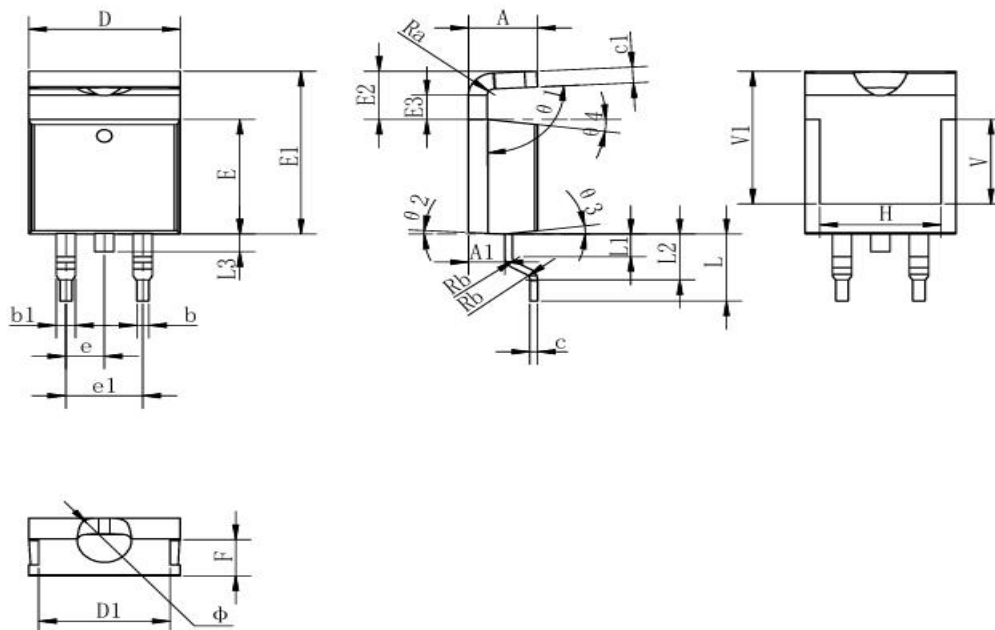
Power dissipation



Maximum Transient Thermal Impedance



Safe Operation Area

TO-220R Package Information


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.30	4.80	0.169	0.189
A1	2.20	2.70	0.087	0.106
b	0.70	0.95	0.028	0.037
b1	1.10	1.50	0.043	0.059
c	0.40	0.65	0.016	0.026
c1	1.20	1.45	0.047	0.057
D	9.70	10.30	0.382	0.406
D1	8.70 Ref.		0.343 Ref.	
E	8.75	9.65	0.344	0.380
E1	12.85	13.85	0.492	0.516
E2	3.95	4.55	0.156	0.179
E3	1.27	2.07	0.050	0.080
e	2.540 Typ.		0.100 Typ.	
e1	4.98	5.18	0.196	0.204
F	2.60	3.00	0.102	0.118
H	7.00	8.40	0.276	0.331
L	5.10	5.50	0.201	0.217
L1	1.35	1.75	0.053	0.069
L2	2.50	2.90	0.098	0.114
L3	1.30	1.50	0.051	0.059
V	6.70 Ref.		0.264 Ref.	
V1	10.45	11.45	0.411	0.451
φ	3.45	3.75	0.136	0.148
θ1	90°	93.5°	90°	93.5°
θ2	0°	6°	0°	6°
θ3	4°	10°	4°	10°
θ4	4°	10°	4°	10°
Ra	0.40	0.90	0.016	0.035
Rb	0.30	0.70	0.012	0.027